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# Interlayer engineering via alkaline hypophosphates for efficient and air-stable perovskite solar cells†

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The energy level mismatch and unfavorable interfacial reaction between nickel oxide (NiO<sub>x</sub>) and organic cations of the perovskite are the main factors affecting the power conversion efficiency (PCE) of inverted perovskite solar cells. Herein, interlayer engineering via dual-functional alkaline hypophosphite is introduced between the nickel oxide hole transport layer (HTL) and the perovskite layer. The introduction of alkaline hypophosphite deepens the valence band maximum of NiO<sub>x</sub>, which better aligns the energy band of perovskite solar cells with the best energy level matching using sodium hypophosphite. In addition, the deposition of alkaline sodium hypophosphite on  $NiO_x$  reduces the proportion of Ni<sup>3+</sup> and slows down the accelerated degradation of the perovskite layer caused by the reaction of excess  $Ni^{3+}$  with organic cations in the perovskite. The open-circuit voltage ( $V_{OC}$ ) of devices treated with sodium hypophosphite increased from 1.01 to 1.08 eV with a power conversion efficiency of 19.92%. Moreover, the unencapsulated devices retained 80% efficiency for 1000 hours under ambient conditions (50-60% relative humidity), and demonstrate a feasible and effective strategy for the fabrication of efficient and air-stable inverted perovskite solar cells.

### Introduction

Organic-inorganic halide perovskite solar cells (PSCs) have garnered increasing attention over the past decade due to their commercial potential and dramatic increase in power conversion efficiency (PCE) from an initial 3.8% to 25.7%. 1,2 PSCs have unique semiconducting properties that enable the fabrication of photovoltaic devices with normal (n-i-p) or inverted (p-i-n) configurations.3 Among these, inverted PSCs have attracted much attention due to their simple fabrication process, negligible hysteresis, low cost and excellent compatibility with tandem photovoltaics. However, the individual optoelectronic properties of inverted PSCs need to be further improved, especially the open-circuit voltage  $(V_{\rm OC})$  and the short-circuit current density ( $J_{SC}$ ). In addition, factors such as moisture and oxygen in the environment can lead to the degradation of device performance. Meanwhile, in inverted PSCs, interface degradation is more severe and leads to nonradiative recombination

losses at the carrier transport layer/perovskite interface. Therefore, improving the efficiency and stability of inverted PSCs is still an important issue for the commercial roadmap.<sup>5,6</sup>

Selecting an inorganic material as a hole transport layer (HTL) is a good way to improve the optoelectronic properties and long-term stability of inverted PSCs. Compared with traditional organic hole transport materials, inorganic hole transport materials have more stable chemical stability and better hole mobility, and the cost is relatively lower. Nickel oxide (NiO<sub>r</sub>) is widely used as a hole transport layer in inverted perovskite solar cells.<sup>8,9</sup> It has the advantages of a low band gap, high transmittance, and wide valence band edge. 10-12 However, the interface defects between NiO<sub>x</sub> and the perovskite layer, mismatched energy level arrangement and charge distribution affect its performance and device stability is also affected by ion migration and the resulting chemical reaction and degradation.<sup>13</sup> To date, a great deal of research has been done to address these issues, especially regarding interface modification. Cheng et al. modified NiO<sub>x</sub> with dipole molecule n-butylamine, and the density of defect states for the modified film decreased significantly. 14 Chen et al. made NiOx with F6TCNNQ, which could reduce the shift level between perovskite and NiO<sub>x</sub>, which inhibits the voltage loss. 15 Zhang et al. presented a self-assembled small-molecule to anchor NiO<sub>r</sub> and perovskite crystals, achieving dual passivation and suppressing

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adverse reactions at the NiO<sub>x</sub>-perovskite interface. <sup>16</sup> Zhang et al. investigated the effect of CsBr modified layers on interfacial stress. The optimized interfacial hole extraction capability was significantly improved and the device obtained the highest efficiency of 19.7%. 17 According to our research, the majority of research studies to date have used organic small molecules and materials that were self-synthesized to modify the surface of NiO<sub>r</sub>. This makes the process more difficult and expensive, which is not advantageous for commercialization. As a result, we have chosen a simple and cost-effective way to prepare perovskite solar cells.

In this work, we explored the effect of alkaline hypophosphates (NaH<sub>2</sub>PO<sub>2</sub> and KH<sub>2</sub>PO<sub>2</sub>) by interfacial passivation of the  $NiO_x$  layer on the performance of inverted PSCs. The introduction of hypophosphite can deepen the valence band maximum of the NiO<sub>x</sub> film, achieving the optimal energy level matching of  $NiO_x$  and the perovskite layer. Besides, the degradation of the perovskite due to the reaction of Ni<sup>3+</sup> with perovskite cations (MA<sup>+</sup> and FA<sup>+</sup>) is slowed down, and the stability of the device is enhanced. Secondly, the introduction of an intermediate layer passivated the surface defects making a substantial increase in  $V_{\rm OC}$ . Ultimately, a champion PCE of 19.92% along with a  $V_{\rm OC}$  of 1.08 V, a  $J_{SC}$  of 22.98 mA cm<sup>-2</sup>, and an FF of 80.13% is achieved. In addition, the unencapsulated devices retain more than 80% of their initial PCE value after 1000 hours of storage in ambient air at 50-60% relative humidity (RH).

## Results and discussion

In this study, a MH<sub>2</sub>PO<sub>2</sub> (MH<sub>2</sub>PO<sub>2</sub>, where M denotes Na or K) passivation layer was introduced between NiOx and the perovskite absorption layer using a post-treatment strategy. The structure of the device and its ideal molecular structure formula are shown in Fig. 1(a), and it is not obtained from atomistic simulations like DFT. Firstly, the effect of the MH<sub>2</sub>PO<sub>2</sub> layer on the band structure is studied. The ultraviolet photoelectron spectra (UPS) of different NiOx films are shown in Fig. 1(b). The WFs (work functions) of NaH2PO2 and KH2PO2 modified NiOx were measured to be 4.28 eV and 4.27 eV, slightly up shifted about 0.06 eV and 0.05 eV compared with that of pristine NiO<sub>x</sub> (4.34 eV). The VBM values of NaH<sub>2</sub>PO<sub>2</sub> and KH<sub>2</sub>PO<sub>2</sub> modified NiO<sub>x</sub> were 1.12 eV and 1.08 eV, down shifted to 0.12 eV and 0.08 eV compared with that of pristine  $NiO_x$  (1.00 eV). Therefore, after modification by NaH<sub>2</sub>PO<sub>2</sub> and KH<sub>2</sub>PO<sub>2</sub>, the HOMO levels of the pristine NiO<sub>x</sub> (5.34 eV) were shifted to 5.40 eV and 5.35 eV. 18 Fig. 1(c)) shows the energy diagram of the device. After NaH2PO2 modification, the HOMO level of the HTL is closer to the VBM of the perovskite (5.4 eV), which minimizes the energy level mismatch at the HTL/ perovskite interface and increases  $V_{oc}$ .<sup>19</sup>

Kelvin probe force microscopy (KPFM) was performed to further investigate the effect of MH<sub>2</sub>PO<sub>2</sub> on the electronic energy levels of NiO<sub>x</sub> thin films. In Fig. 2a-c, the surface increased compared to the pristine NiO<sub>x</sub> film, indicating that the MH<sub>2</sub>PO<sub>2</sub> treatment reduced the work function of NiO<sub>x</sub>. This is consistent with the UPS results. The surface morphology of NiOx under different treatments was investigated by the atomic force microscopy (AFM) measurement. Obviously, the MH2PO2 modification has a slight change in the surface morphology of the NiO<sub>x</sub> films, as shown in Fig. 2d-f. The X-ray photoemission spectrum (XPS) analysis is performed to explore the element composition of the NiO<sub>x</sub> films. Fig. 1(d) displays the XPS Ni  $2p_{3/2}$  spectra. The ratios of Ni<sup>3+</sup>/Ni<sup>2+</sup> calculated from the integral area in the Ni 2p spectrum are decreased from the pristine NiO<sub>r</sub> to the modified films. Previous studies have shown that the main reason for lower  $V_{oc}$  is the occurrence of the redox reaction between metal cation sites (Ni3+ on the NiOx surface) and the A-site cation (MA+ or FA<sup>+</sup>), and this detrimental reaction generates a PbI<sup>2</sup>-rich hole extraction barrier at the NiOx-perovskite interface, which hinders its intrinsic conductivity and increases charge recombination, resulting in severe  $V_{\rm OC}$  loss. <sup>20,21</sup> The reaction between the perovskite and NiO<sub>x</sub> is shown in the following reaction, where HA<sup>+</sup> is a protonated A-site cation (CH<sub>5</sub>N<sub>2</sub><sup>+</sup>or FA<sup>+</sup>, CH<sub>3</sub>NH<sub>3</sub><sup>+</sup> or MA<sup>+</sup>) and A is the deprotonated A-site cation (CH<sub>4</sub>N<sub>2</sub>, CH<sub>3</sub>NH<sub>2</sub>).

$$HAPbI_{3} + Ni^{\geq 3+}O_{\it{X}} \leftrightarrow Ni^{\geq 2+}O_{\it{X}}H + PbI_{2} + A_{(g)} + \frac{1}{2}I_{2(g)} \ \ \mbox{(1)}$$

Furthermore, it accelerates the degradation of the perovskite by deprotonation of the precursor amine and oxidation of iodide to interstitial iodine, resulting in severe device instability.<sup>22</sup> Thus, the modified NiO<sub>x</sub> effectively suppresses the generation of crystal defects and the degradation of the perovskite layer, which is the main reason for the improved device stability. In addition, a shift of the Ni 2p3/2 peak to a lower binding energy is observed, indicating a charge transfer between NiO<sub>x</sub> and H<sub>2</sub>PO<sub>2</sub>-.<sup>23-25</sup> The O 1s spectrum in Fig. 1(e) also has a shift in the peak position and a significant increase in the peak intensity, which leads to a change in the surface dipole and thus a shift in the vacuum energy level at the interface, facilitating hole injection into the hole transport layer.26 Besides, the peak of P 2p can be clearly observed in the NiOx-MH2PO2 modified film (Fig. S1a, ESI†), while the peak of the P element does not appear in the pristine NiOx, which can prove the existence of the H2PO2molecule in the NiO<sub>x</sub>-MH<sub>2</sub>PO<sub>2</sub> modified film. And the Na and K peaks in the modified film compared to the pristine thin film are shown in Fig. S1b and c (ESI†).

Fig. 3(a-c) shows the scanning electron microscopy (SEM) images of perovskite films. A slight increase in the average crystal size after modification was found compared to the pristine film, which was calculated using the Nano Measurer software (Fig. 3d). It is evident from the grain size distribution map of the perovskite films that the average grain size of the NiOx films modified by KH2PO2 increases the most, from 306 nm to 408 nm compared to the pristine films. Meanwhile, the cross-sectional SEM of the device is shown in Fig. S2 (ESI†). Fig. 3(e) shows the X-ray diffraction (XRD) patterns of the pristine and MH<sub>2</sub>PO<sub>2</sub>-modified perovskite films. It can be seen from the figure that the main peaks of the perovskite film are mainly located in 13.90°,19.80°, 24.31°, 28.20°, and 31.65°, which belong to the (001), (011), (111), (002), and (012) crystal planes of the cubic perovskite. The full-width half-maximum

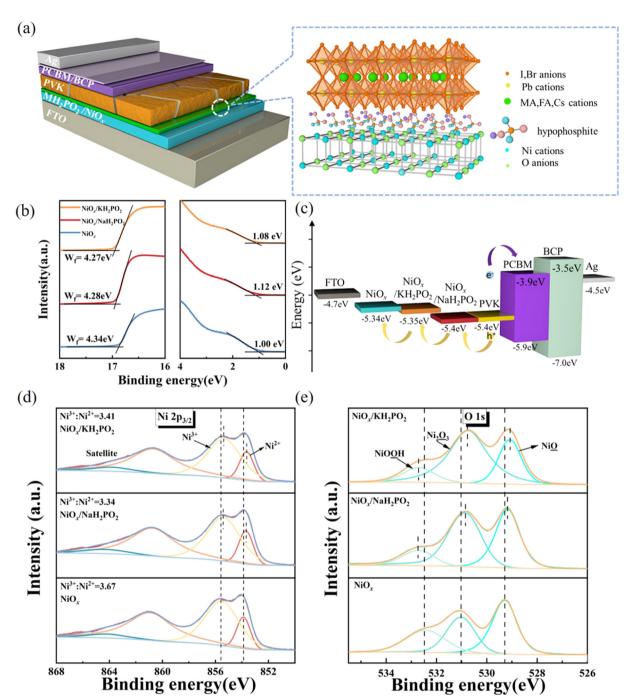


Fig. 1 (a) Schematic diagram of the device structure and ideal molecular arrangement structure (not obtained from atomistic simulations). (b) UPS of NiO<sub>x</sub> and NiO<sub>x</sub>/MH<sub>2</sub>PO<sub>2</sub>. (c) Energy level diagram of the perovskite solar cells (PSCs) (data for the corresponding NiO<sub>x</sub> films are provided by the UPS measurement). High resolution XPS spectra of (d) Ni and (e) O elements in NiO<sub>x</sub> with and without MH<sub>2</sub>PO<sub>2</sub> modification.

(FWHM) of modified crystal planes is narrower compared to the control device, as shown in Fig. 3(f), indicating an increase in grain size, the change of grain diameter is consistent with SEM. The ratio of peak intensities is calculated to further explore the effect on crystal orientation, (002)/(001) for different films. It was found that the (002)/(001) peak intensity ratio gradually increased after MH<sub>2</sub>PO<sub>2</sub> modification, and the highest value of this ratio was observed in the NaH<sub>2</sub>PO<sub>2</sub>-modified devices, which exhibited the meritocratic orientation of the (001) crystal face. Moreover, the selective orientation on the (001) crystal plane facilitates the carrier transport at the interface. 27-29 The UV-vis transmittance of the modified film was studied as shown in Fig. S3a (ESI†). The transmittance of the modified  $NiO_x$  film in the visible light range is basically the same as that of the pristine film. Therefore, the introduction of the modification layer does not affect the performance of the device by reducing the transmittance of the film. Fig. 4(a) shows the UV-vis absorption spectrum of the perovskite film with increased light absorption

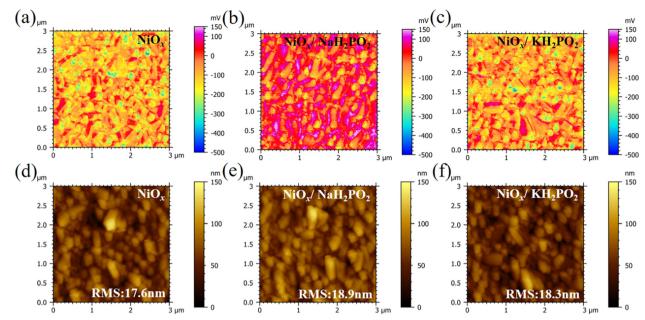


Fig. 2 Surface potentials of the (a) pristine  $NiO_x$ , (b)  $NaH_2PO_2$  modified  $NiO_x$  substrate, and (c)  $KH_2PO_2$  modified  $NiO_x$  substrate. AFM images of the (d) NiO<sub>x</sub>, (e) NaH<sub>2</sub>PO<sub>2</sub> modified NiO<sub>x</sub> thin film, and (f) KH<sub>2</sub>PO<sub>2</sub> modified NiO<sub>x</sub> thin film.

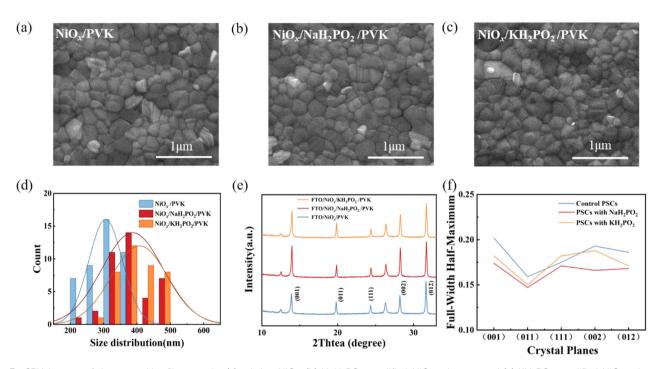


Fig. 3 SEM images of the perovskite films on the (a) pristine NiO<sub>x</sub>, (b) NaH<sub>2</sub>PO<sub>2</sub> modified NiO<sub>x</sub> substrate and (c) KH<sub>2</sub>PO<sub>2</sub> modified NiO<sub>x</sub> substrate. (d) Histograms of the grain size (scale of data: 43 devices). (e) X-ray diffraction patterns of FTO/NiO<sub>x</sub>/PVK, FTO/NiO<sub>x</sub>/NaH<sub>2</sub>PO<sub>2</sub>/PVK and FTO/NiO<sub>x</sub>/ KH<sub>2</sub>PO<sub>2</sub>/PVK. (f) Full-width half-maximum of XRD peaks for perovskite films with different devices.

in the wavelength range of 300 to 500 nm. This is due to the increase in light scattering caused by the increase in surface roughness, so the UV-vis spectra show an increase in light absorption, which contributes to the improvement of  $J_{SC}$ .<sup>30</sup> Fig. S3b (ESI†) shows that the surface hydrophilicity of the modified NiO<sub>x</sub> film decreases from 17.53° to 10.59°(NaH<sub>2</sub>PO<sub>2</sub>)

and 9.77°(KH<sub>2</sub>PO<sub>2</sub>). This is favorable for subsequent perovskite deposition.<sup>31</sup> Firstly, the effect of modification on the film quality is studied from the perspective of crystallography.

To further elucidate the interfacial modification effect of alkali hypophosphite, steady-state photoluminescence (PL) and time-resolved photoluminescence (TRPL) measurements were

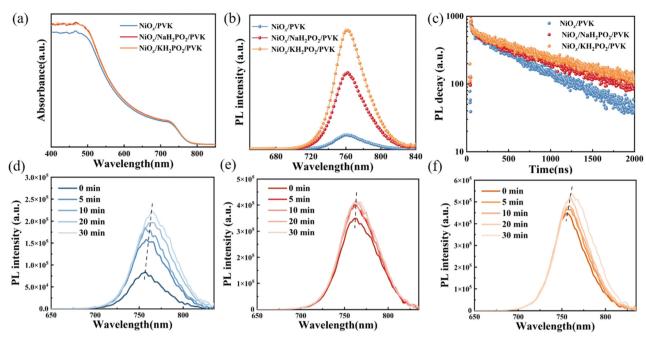


Fig. 4 (a) UV-vis absorption spectra of the NiO<sub>x</sub> films with and without MH<sub>2</sub>PO<sub>2</sub>. (b) Steady PL spectra and (c) TRPL spectra of FTO/NiO<sub>x</sub>/PVK, FTO/NiO<sub>x</sub>/  $NaH_2PO_2/PVK \ and \ FTO/NiO_x/KH_2PO_2/PVK. \ (d-f) \ PL \ spectra \ of \ perovskite \ films \ deposited \ on \ NiO_x, \ NiO_x/NaH_2PO_2 \ and \ NiO_x/KH_2PO_2 \ under \ standard \ normal \ normal$ AM 1.5 irradiation (100 mW cm<sup>-2</sup>) for different times.

performed, respectively (Fig. 4(b) and (c)), and the obtained results are shown in Table S1 (ESI†). The samples modified with NaH<sub>2</sub>PO<sub>2</sub> and KH<sub>2</sub>PO<sub>2</sub> exhibit stronger luminescence intensity compared to that of the modified films, which is the same as the previous study on the interfacial modification of alkali metal salts, indicating the suppression of non-radiative recombination. 32,33 Secondly, the luminescence intensity of KH<sub>2</sub>PO<sub>2</sub> is higher than that of NaH<sub>2</sub>PO<sub>2</sub>, and that of the modified devices is significantly greater than that of the original devices. This suggests effective quasi-Fermi-level splitting, which may be the reason for the increased  $V_{\rm OC}$ . However, the TRPL test results show an extended decay lifetime, which implies a slower carrier extraction rate. The lifetime of KH<sub>2</sub>PO<sub>2</sub> (984.79) modified is longer than that of NaH<sub>2</sub>PO<sub>2</sub> (863.07), and the lifetimes of both are higher than that of the pristine film (660.81), which implies a slower carrier extraction rate. This seems to be contrary to our idea of interfacial modification of NiO<sub>x</sub>, so we can infer that MH<sub>2</sub>PO<sub>2</sub> has a dual role here. On the one hand, MH<sub>2</sub>PO<sub>2</sub> can reduce non-radiative surface recombination, passivate surface defects, and prevent NiOx from reacting unfavorably with the perovskite film. On the other hand, the longer decay lifetime of perovskite films formed on the NiOx-MH<sub>2</sub>PO<sub>2</sub> substrates shows a slower rate of recombination, which is attributed to the passivation of grain boundaries by alkali metal ions. Also, because the enhanced steady-state luminescence intensity also mitigates the nonradiative recombination, with longer carrier lifetimes allowing an increase in  $J_{SC}$ . However, because the carrier lifetime of KH<sub>2</sub>PO<sub>2</sub> is increased by about onethird compared to the pristine device, the hole extraction rate is too slow, which affects its  $V_{\rm OC}$ , and the defect state density of NaH<sub>2</sub>PO<sub>2</sub> is smaller compared to that of KH<sub>2</sub>PO<sub>2</sub>. Maybe this is

the reason why the  $V_{OC}$  of  $KH_2PO_2$  is not as good as that of NaH<sub>2</sub>PO<sub>2</sub>. It has been reported that alkali metal cations can suppress ion migration.<sup>34,35</sup> Therefore, we placed the pristine films and the modified films under continuous irradiation of light to observe the change in the PL intensity. With the increasing illumination time, a clear increase in fluorescence intensity and a red shift of the PL peak can be observed in the pristine film (Fig. 4(d)), indicating an increase in interfacial defects and aggravation of interfacial reactions, 16 while the NaH2PO2-modified films show a relatively little change (Fig. 4(e)). The reason for the increase in luminescence intensity with illumination time in perovskite films is due to Ii defects and iodide migration.36 Therefore, NaH2PO2 has a certain effect on reducing nonradiative recombination, suppress ion migration, and accelerate the transport of photocarriers; thus, devices with better optoelectronic properties can be obtained. This may be one reason why the NaH<sub>2</sub>PO<sub>2</sub>-modified device performs better.

To further investigate the interfacial traps and recombination, Fig. 5(a) displays the extended C-V curves that directly compare the built-in potential of the devices by the Mott-Schottky analysis using the following equation<sup>37</sup>

$$C^{-2} = \frac{2(V_{\rm bi} - V)}{A^2 q \varepsilon_0 \varepsilon N} \tag{2}$$

where A is the device area,  $\varepsilon$  is the dielectric constant,  $\varepsilon_0$  is the vacuum permittivity,  $V_{bi}$  is the built-in potential, N is the charge density, and V is the applied bias. We can clearly see the enhancement of the built-in potential, which contributes to the increase of  $V_{\rm OC}$ , and the slope of the linear region of Mott-Schottky plots is inversely proportional to carrier density.<sup>38</sup> The increase in carrier density illustrates the effect of MH2PO2

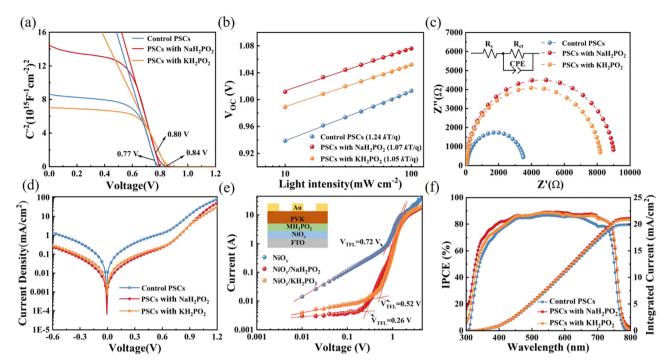


Fig. 5 (a) Mott–Schottky plot of capacitance–voltage measurements of devices based on different HTLs. (b)  $V_{\rm OC}$  as a function of light intensity. (c) EIS of PSCs in the dark; the inset shows the equivalent circuit. (d) Dark J-V curves of devices with different NiO<sub>x</sub>-based HTLs. (e) Dark J-V curves with the SCLC model based on the device structure of FTO/NiO<sub>x</sub>/Au or MH<sub>2</sub>PO<sub>2</sub>-modified NiO<sub>x</sub>/PVK/Au. (f) IPCE spectrum together with the integrated  $J_{SC}$  of the PSCs.

passivation. The dependence of  $V_{\rm OC}$  on light intensity is indicated in Fig. 5(b), showing a semi-logarithmic plot of the incident light intensity dependence of  $V_{\rm OC}$ , which is linearly fitted by the following equation:<sup>18</sup>

$$V_{\rm OC} = nKT \ln(I)/q + C \tag{3}$$

where n is the ideal factor to judge the dominant recombination mechanism, k is the Boltzmann constant, T is the absolute temperature, q is the elementary charge, I is the fractional light intensity normalized to one sun, and C is a constant. The decreased n value in the MH<sub>2</sub>PO<sub>2</sub>-modified devices indicates a certain inhibitory effect on trap-assisted recombination, which is the same as the increasing trend of  $V_{\rm OC}$ . To explore charge transport on the interface, EIS is carried out under a 0.9 V bias in the dark. Nyquist plots and the proposed model of the equivalent circuit are displayed in Fig. 5(c). 39,40

Corresponding values of series resistance  $(R_s)$  and charge transfer resistance ( $R_{\rm ct}$ ) are summarized in Table S2 (ESI†). The larger semicircle of devices compares pristine (3476  $\Omega$ ) to those modified with NaH<sub>2</sub>PO<sub>2</sub> (9033  $\Omega$ ) and KH<sub>2</sub>PO<sub>2</sub> (8187  $\Omega$ ) shows the enhanced  $R_{ct}$ , indicating that charge recombination at the perovskite/HTL is suppressed.<sup>23</sup> Furthermore, the dark-current curves versus bias voltage (-0.6 to 1.2 V) of the pristine and modified devices shown in Fig. 5(d), which also verifies the reduction of trap content. Compared with the pristine NiO<sub>x</sub> and KH<sub>2</sub>PO<sub>2</sub> in the work bias region, the leakage current of the NaH<sub>2</sub>PO<sub>2</sub> modified device is smaller, which is beneficial to the improvement of  $J_{SC}$ . Space-charge-limited-current (SCLC) is used to measure the hole transport process to estimate the internal trap density of the device. The hole-only device was constructed with FTO/NiO<sub>x</sub>/PVK/Au and FTO/MH<sub>2</sub>PO<sub>2</sub>-modified NiO<sub>x</sub>/PVK/Au structures (Fig. 5(e)). It is found that the NaH<sub>2</sub>PO<sub>2</sub>modified device exhibits a lower density of defect states  $(6.06 \times 10^{12} \text{ cm}^{-3})$  compared to those of the pristine device  $(1.68 \times 10^{13} \text{ cm}^{-3})$  and KH<sub>2</sub>PO<sub>2</sub>-based device  $(1.21 \times 10^{13} \text{ cm}^{-3})$ , which is consistent with the previous test results. This shows that NaH<sub>2</sub>PO<sub>2</sub> can reduce the defect density between NiO<sub>x</sub> and the perovskite layer and improve the  $V_{\rm OC}$  of the device. 42,43 Overall, the application of MH<sub>2</sub>PO<sub>2</sub>-modified NiO<sub>x</sub> can facilitate charge transport at the perovskite/HTL and reduce carrier recombination, mainly due to improved electrical conductivity, optimized interfacial energy alignment, and suppressed interfacial defects, thereby significantly improving the photovoltaic performance of the device.

We have demonstrated the beneficial effect of an alkali metal hypophosphite passivation strategy to improve PSC performance. The  $FTO/NiO_x/MH_2PO_2/(CsPbI_3)_{0.05}[(FAPbI_3)_{0.85}(MAPbBr_3)_{0.15}]_{0.95}/$ PC61BM/BCP/Ag structure was used to further study the photovoltaic performance of PSCs. After experiments, NaH<sub>2</sub>PO<sub>2</sub> and KH<sub>2</sub>PO<sub>2</sub> exhibited the best PCE in the device at a concentration of 4 mg mL $^{-1}$  (Fig. S4, ESI†). And in Fig. 6(a) and Table 1 we can observe an obvious improvement of photovoltaic performance, as well as stabilized  $J_{SC}$  and efficiency. Fig. 6(b) compares the J-Vcurves of the best device based on pristine NiOx and modified films with MH<sub>2</sub>PO<sub>2</sub>. Furthermore, there is an excellent agreement between the short-circuit current density values from the experiments and those estimated from the measured external quantum efficiency (EQE) spectra in Fig. 5(f). Clearly, the fill factor (FF) difference between devices under different conditions is negligible. The improvement of  $V_{\rm OC}$  and  $J_{\rm SC}$  is the main factor to improve the efficiency of the device. The pristine device

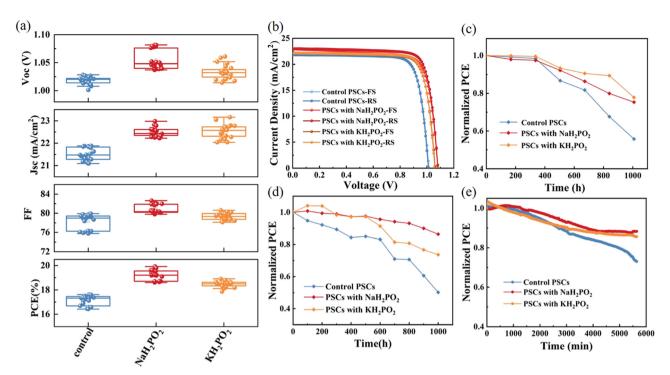


Fig. 6 (a) Photovoltaic parameter statistics for the investigated PSCs extracted by the J-V characteristics. (b) Stabilized J-V curves of the bestperforming devices with different modification layers compared with control devices. (c) Long-term normalized stability of PSCs with pristine NiO<sub>x</sub> and  $MH_2PO_2$  modified  $NiO_x$  HTLs (under ambient air with a relative humidity of 50–60%). (d) Normalized averaged PCE of the corresponding devices kept under a N2 atmosphere at 60 °C for 1000 h. (e) Operational stability tests by tracking their MPP under 1-sun equivalent white LED illumination. Values are normalized to the initial PCE at MPP

Table 1 Summary of photovoltaic parameters for the inverted PSCs with pristine and modified NiOx HTLs

Devices	Sweep	$V_{\mathrm{OC}}\left(\mathbf{V}\right)$	$J_{\rm SC}~({ m mA~cm}^{-2})$	FF	PCE (%)
$\overline{\mathrm{NiO}_x}$	FS	1.01	21.82	79.58	17.62
	RS	1.01	21.79	79.91	17.60
NiO <sub>x</sub> /NaH <sub>2</sub> PO <sub>2</sub>	FS	1.08	22.93	77.04	19.10
	RS	1.08	22.98	80.13	19.92
NiO <sub>x</sub> /KH <sub>2</sub> PO <sub>2</sub>	FS	1.06	22.16	79.86	18.78
	RS	1.06	22.16	80.62	18.91

exhibited a PCE of 17.86%, with a  $V_{\rm OC}$  of 1.02 V, a  $J_{\rm SC}$  of 21.87 mA cm<sup>-2</sup>, and an FF of 79.73%. However, the NaH<sub>2</sub>PO<sub>2</sub>modified NiO<sub>x</sub>-based device shows the best performance with a maximum PCE of 19.92%, a  $V_{\rm OC}$  of 1.08 V, a  $J_{\rm SC}$  of 22.98 mA cm<sup>-2</sup>, and an FF of 80.13%.

The long-term stability of devices is also an important factor restricting commercial development. Therefore, the long-term stability of the pristine and modified devices after 1000 h storage in ambient air at 50-60% relative humidity was investigated. As shown in Fig. 6(c), the performance of the pristine device dropped below 60% after 1000 hours, while that of the MH<sub>2</sub>PO<sub>2</sub>-modified device retained around 80% of the initial efficiency during the same period. It was confirmed that the introduction of the MH<sub>2</sub>PO<sub>2</sub> modification layer is beneficial to improve the air stability of the device, as the MH<sub>2</sub>PO<sub>2</sub> buffer layer can improve the perovskite/HTL interfacial contact and perovskite crystallinity, thereby mitigating water intrusion or penetration. 17,44 In addition, the PCE of the NaH2PO2-based

device can remain above 80% of the initial value after 1000 h storage at 60 °C under a nitrogen atmosphere (Fig. 6(d)), while the performance of the pristine device is severely degraded. The operational stability of the unencapsulated pristine device and the MH<sub>2</sub>PO<sub>2</sub> modified devices are also tested under continuous 1 sun illumination (achieved by a white-light LED array) with MPP tracking in ambient air as shown in Fig. 6(e). 45-47 The MH<sub>2</sub>PO<sub>2</sub> modified device maintained around 90% of its initial PCE after 6000 min, much higher than that of the pristine device (70%). The effective defect passivation on the perovskite surface and the enhancement of perovskite crystallinity makes the stability of MH<sub>2</sub>PO<sub>2</sub> modified devices significantly enhanced under different conditions. These test results confirm the impressive role of MH<sub>2</sub>PO<sub>2</sub> in improving the long-term stability of the devices.

### Conclusions

Through interface engineering, the NiO<sub>x</sub> interface defects are passivated via alkaline hypophosphates. The energy level can be altered to improve the hole transport efficiency by adding NaH<sub>2</sub>PO<sub>2</sub> to modify NiO<sub>x</sub>. Additionally, by preventing the damaging redox processes at the NiOx/perovskite interface, the degradation of the perovskite layer is slowed down, increasing the device's stability. Furthermore, the devices changed by NaH<sub>2</sub>PO<sub>2</sub> have a lower trap-state density, which improves  $V_{\rm OC}$ . Therefore, the NiO<sub>x</sub>/NaH<sub>2</sub>PO<sub>2</sub>-based PSCs show champion PCE values with a negligible hysteresis increase from 17.60% to 19.92%, a  $V_{\rm OC}$ 

increase from 1.01 V to 1.08 V, and a  $J_{\rm SC}$  increase from 21.79 mA cm<sup>-2</sup> to 22.98 mA cm<sup>-2</sup>. Meanwhile, the NaH<sub>2</sub>PO<sub>2</sub>modified device also exhibits excellent long-term stability, maintaining 80% of the initial efficiency after being stored in air at 50-60% RH for 1000 h. This simple and economical passivation strategy provides a new approach for preparing efficient and stable PSCs as well as commercializing them for applications.

## **Experimental**

#### **Materials**

Methyl-ammonium bromine (MABr, ≥99.5%), lead(II) iodide (PbI<sub>2</sub>, >99.99%), formamidinium iodide (FAI,  $\geq$ 99.5%), lead( $\pi$ ) bromine (PbBr<sub>2</sub>, >99.99%), 2,9-dimethyl-4,7-dipheny l-1,10phenanthroline (BCP, >99%), and cesium iodide (CsI, >99.99%) were manufactured from Xi'an Polymer Light Technology Corp. Ethanol (ET, 99.5%), isopropanol (IPA, 99.8%), sodium hypophosphite monohydrate (NaH<sub>2</sub>PO<sub>2</sub>·H<sub>2</sub>O, 99%), ethanolamine (ETA, 99%), and potassium hypophosphite (KH<sub>2</sub>PO<sub>2</sub>, 99%) were brought from Aladdin. Chlorobenzene (CB, 99.8%), N,Ndimethylformamide (DMF, 99.8%), ethyl acetate (EA, 99.8%), and dimethyl sulfoxide (DMSO, 99.9%) were purchased from Sigma-Aldrich. [6,6]Phenyl C-61-butyric acid methyl ester (PC<sub>61</sub>BM, 99.5%) and nickel(II) acetate tetrahydrate (Ni-(CH<sub>3</sub>COOH)<sub>2</sub>·4H<sub>2</sub>O, 99%) were manufactured by Organtec Ltd and Acros Organics, respectively. All chemicals and solvents were used directly as received.

#### **Device fabrication**

The device was made using an FTO glass substrate that measures  $1.6 \times 2$  cm<sup>2</sup>. Detergent, ethanol, acetone, and ethanol are all used to wash the FTO glass for 15 minutes. The substrates are then moved into a UV-ozone oven for 10 minutes. NiOx precursor solutions are made according to earlier publications. 48 The NiO<sub>x</sub> precursor solution was created by dissolving Ni-(CH3COOH)2.  $4H_2O$  (25 mg mL<sup>-1</sup>) in ethanol, adding 6  $\mu$ L of ETA additive per mL, and agitating the mixture for 8 hours at 60 °C. After this, the NiO<sub>x</sub> solution was produced, deposited onto the FTO substrate for 40 s at 1500 rpm, and then annealed for 60 min in an atmosphere of air at 300 °C. The corresponding powders were added to deionized water and stirred for 2 hours to obtain MH<sub>2</sub>PO<sub>2</sub> solutions of different concentrations. The MH<sub>2</sub>PO<sub>2</sub> solution was deposited on the NiO<sub>x</sub> layer by spin-coating at 1500 rpm. for 30 s and annealed at 150  $^{\circ}\text{C}$  for 10 min. The perovskite precursor solution (FAI:MABr:CsI:PbI<sub>2</sub>:PbBr<sub>2</sub> = 199.8 mg:26.7 mg:18.2 mg:573.9 mg:87.4 mg dissolved in 1 mL of DMF: DMSO = 4:1 (v/v), and stirred at 60 °C for 1 h) was spin coated on pure or modified NiO<sub>x</sub> at 3000 rpm for 35 s. After 27 s of spin-coating, 200 L of ethyl acetate was swiftly dropped over the substrates. Then, 20 mg mL<sup>-1</sup> PC<sub>61</sub>BM was dissolved in chlorobenzene and fabricated on the perovskite film at 1500 rpm for 40 s and annealed at 80 °C for 10 min. Then, the coating was spun at 4000 rpm for 30 s for 0.5 mg mL<sup>-1</sup>, 30 s in isopropanol solution. Finally, heat evaporation was used to deposit a 100 nm thick Ag electrode on the film surface.

#### Characterization

Ultraviolet photoelectron spectroscopy (UPS) was performed using a PHI 5000 VersaProbe III with He I source (21.22 eV) under an applied negative bias of 9.0 V. The external quantum efficiency (EQE) was performed using a Bentham PVE300 Photovoltaic Device Characterization System from 300 nm to 800 nm. The scanning electron microscopy (SEM) image films were observed using a scanning electron microscope (FEI INSPECT F50, U.S.A.). X-ray diffraction (XRD) measurements were performed using a X-ray diffractometer (PANalytical B.V., X' Pert Pro MPD). A ESCALAB 250Xi instrument with a monochromatized Al Kα X-ray source in vacuum was used to perform XPS measurements. Illumination was provided using an AAA Class Simulator (SS-F5-3A, Enli Technology Co., Ltd) under an AM 1.5G spectrum and a light intensity of 100 mW cm<sup>-2</sup>. AFM and KPFM images (KEYSIGHT 7500 AFM/STM) were characterized to study the surface morphology and surface potentials. The PL and TRPL images were recorded using an Edinburgh FLS 980 spectrophotometer.

## Conflicts of interest

There are no conflicts to declare.

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